These new AlN-Al₂O₃ compounds derived above completely confirm two of the 'sialon' phases postulated by Jack (1976) in the Si-Al-O-N system. In fact they can be considered as prototypes of his tetrahedral AlN 'polytypes' having M/X ratios of 10/11 and 9/10, respectively. In his phase diagram for Si_3N_4 -AlN-Al₂O₃-SiO₂, the 27R line should now be extended to the join between Al₂O₃ and AlN. Furthermore, another line for the 20H structure should intersect this join to account for the existence of Al₁₀N₈O₃. It is of interest to note that although many crystals of this 20Hcompound were well ordered, others from the same preparation showed considerable streaking along the h0lrows on Weissenberg photographs. This indication of disorder is caused by mistakes in the stacking arrays along the c axis. The rhombohedral crystals of $Al_0N_7O_3$ exhibited a higher degree of order, probably because less faulting occurs for shorter 9Al-atom segments which characterize the structure of this compound. This type of disorder is common in SiC and other such polytypic compounds (Verma & Krishna, 1966).

Although the crystal structure has not been refined from single-crystal Weissenberg photographs, the idealized arrangement postulated by Jack (1976) gives reasonably good agreement with the observed intensities. Projections of the 20H and 27R structures on the hexagonal (110) plane are illustrated in Fig. 1. Their X-ray diffraction patterns are given in Table 2. Because of the large number of possible reflections only those observable are listed.

We expect further work will reveal other aluminum oxynitride repeated-layer structures. So far these exist for m = 4, 5, 6, 7, and 8.

The authors thank W. S. Knapp for his assistance in growing the crystals.

References

ADAMS, I., AUCOIN, T. R. & WOLF, G. A. (1962). J. Electrochem. Soc. 109, 1050–1054.

- Collongues, R., Gilles, J. C., Lejus, A. M., Perez y Jorba, M. & Michel, D. (1967). *Mater. Res. Bull.* 2, 837–848.
- GAUCKLER, L. J., LUKAS, H. L. & PETZOW, G. (1975). J. Am. Ceram. Soc. 58, 346–347.
- GAUCKLER, L. J. & PETZOW, G. (1977). Nitrogen Ceramics, edited by F. L. RILEY, pp. 41-60. Leiden: Noordhoff.
- GILLES, J. C. (1965). Rev. Int. Hautes Temp. Refract. 2, 237-262.
- JACK, K. H. (1976). J. Mater. Sci. 11, 1135-1158.
- JEFFREY, G. A. & WU, V. Y. (1963). Acta Cryst. 16, 559-566.
- JEFFREY, G. A. & WU, V. Y. (1966). Acta Cryst. 20, 538-547.
- LEFEBVRE, A. (1975). J. Appl. Cryst. 8, 235–242.
- LEJUS, A. M. (1962). Bull. Soc. Chim. Fr. pp. 2123-2126.
- LEJUS, A. M. (1964). Rev. Int. Hautes Temp. Refract. 1, 53-95.
- LONG, G. & FOSTER, L. M. (1961). J. Am. Ceram. Soc. 44, 255-258.
- MICHEL, D. (1972). Rev. Int. Hautes Temp. Refract. 9, 225-241.
- MICHEL, D. & HUBER, M. (1970). Rev. Int. Hautes Temp. Refract. 7, 145–150.
- SAKAI, T. (1978). Yogyo Kyokai Shi, **86**, 125–130.
- SLACK, G. A. (1973). J. Phys. Chem. Solids, 34, 321-335.
- SLACK, G. A. & MCNELLY, T. F. (1976). J. Cryst. Growth, 34, 263–279.
- SLACK, G. A. & MCNELLY, T. F. (1977). J. Cryst. Growth, 42, 560–563.
- THOMPSON, D. P. (1977). *Nitrogen Ceramics*, edited by F. L. RILEY, pp. 129–134. Leiden: Noordhoff.
- VERMA, A. R. & KRISHNA, P. (1966). Polymorphism and Polytypism in Crystals, p. 152. New York: John Wiley.
- VON STACKELBERG, M. & SPEISS, K. F. (1935). Z. Phys. Chem. Abt. A, 175, 140-153.
- YAMAGUCHI, G. & YANAGIDA, H. (1959). Bull. Chem. Soc. Jpn, 32, 1264–1265.

Acta Cryst. (1979). B35, 2283-2284

On the space groups of two thiospinels. By LEONARDO GASTALDI and LUCIO SCARAMUZZA, Laboratorio di Teoria e Struttura Elettronica e Comportamento Spettrochimico dei Composti di Coordinazione del CNR, Via Montorio Romano 36, Roma, Italy

(Received 19 December 1978; accepted 26 April 1979)

Abstract

Single crystals of CuIn₅S₈ and AgIn₅S₈ thiospinels have been examined by X-ray diffractometry, in order to assign the space groups. The ψ scan of some high-angle reflections, forbidden in the conventional space group Fd3m, showed that CuIn₅S₈ belongs to the alternative space group $F\bar{4}3m$. group to the spinel-type compounds. The problem has been described by Thompson & Grimes (1977), who reviewed the results of previous work with electron and neutron diffraction techniques.

The alternative to space group Fd3m, usually assigned to spinels, is $F\bar{4}3m$, where the octahedral-site metal ions are displaced along the [111] directions and the tetrahedral ones split into two crystallographically independent sites, namely 4(a) and 4(c). The space-group assignment is usually based on the detection of hk0 reflections with h + k = 4n + 2, forbidden in Fd3m, but allowed in $F\bar{4}3m$. The difficulty

© 1979 International Union of Crystallography

In the last few years stimulating discussions have been reported in the literature on the correct assignment of space 0567-7408/79/092283-02\$01.00

4 0 6 18 20 22 24 ż à 10 12 14 16 26 28 30 32 36 34 38 # DEGREES 10 0 0 10 12 14 16 20 22 26 30 32 34 36 38 18 24 28 v. DEGREES 10 8 0 ò 10 12 38 2 6 8 14 16 18 20 22 24 26 34 36 v DEGREES 14 4 0 10 12 14 16 18 20 22 24 26 28 30 32 34 36 38 Ó 6 8

Fig. 1. Intensities of four reflections of $CuIn_{s}S_{s}$, taken with the θ - 2θ scan technique at various angles, ψ , around their scattering vectors, with $\Delta \psi = 0.1^{\circ}$. The continuous curve represents the integrated intensity I_0 , corrected for the background, and the dotted line indicates the $3\sigma(I)$ value.

arises from the fact that these reflections are affected by the Renninger effect. Since low-angle reflections (e.g. 200) are affected more in X-ray diffraction than in other techniques, we have examined some high-angle forbidden reflections.

Debye-Scherrer powder films of Culn_sS_e and AgIn_sS_e showed that both have cubic spinel-type structures. For precise determination of lattice constants a Philips camera with the asymmetric Straumanis film mounting was used. Four reflections with $\theta > 65^\circ$ gave the following final cell constants: AgIn₅S₈: a = 10.8268 (5) Å; Culn₅S₈: a =10.6858 (3) Å (the Nelson-Riley function was plotted). Single crystals were mounted on a four-circle Syntex P2, diffractometer; Mo $K\alpha$ ($\lambda = 0.71073$ Å) radiation was used $(\mu = 11.54 \text{ and } 12.21 \text{ mm}^{-1} \text{ respectively})$. The crystal was rotated about the scattering vector of each reflection (ψ angle) and a θ -2 θ scan collection carried out at fixed intervals (0.1°) of ψ . Two background values were measured at 1° below and 1° above the $K\alpha_1$ and $K\alpha_2$ peaks respectively.

The copper compound shows the presence of a considerable number of forbidden reflections, even at relatively high θ values. Four of these, chosen for their remarkable intensities. are plotted in Fig. 1. There are many Renninger peaks, separated by approximately flat regions, where the intensity variations are of the order of three or four times $\sigma(I)$.

The diagrams show, from top to bottom, two plots for each reflection: the intensity I_o corrected for the background, and the $3\sigma(I)$ level.

On the basis of these results Culn₅S₈ can be assigned to space group $F\bar{4}3m$. However, these results could be explained by a non-random distribution of copper and indium ions in the two tetrahedral sites 4(a) and 4(c), so a complete structural determination of this compound has been undertaken.

No forbidden reflections were detected for the silver compound, so we believe that, on the basis of the X-ray diffraction analysis, it must be assigned to the conventional space group Fd3m.

We thank Drs C. Paorici and L. Zanotti of the Laboratorio MASPEC, CNR, Parma, for providing the crystals.

Reference

THOMPSON, P. & GRIMES, N. V. (1977). J. Appl. Cryst. 10, 369-371.

International Union of Crystallography

U. DEGREES

Acta Cryst. (1979). B35, 2284

Radiation leakage around X-ray tube shields

The Union's Commission on Crystallographic Apparatus recommends that the radiation level around X-ray tube shields should be carefully checked, because considerable leakage has been detected in some laboratories. Particular care should be taken when high-energy tubes are used and when tubes made by one manufacturer are enclosed in shields made by a different manufacturer.

Commission on Journals

Acta Cryst. (1979). B35, 2284-2285

Submission of Crystal Structure Manuscripts

Chemical-connectivity relationships in all recent crystal structure manuscripts have been checked by the Co-editors of Acta Crystallographica for internal consistency with the corresponding crystallographic data. As many as 35% of the manuscripts have been found by some Co-editors to contain

١.,

13000

11000

9000

7000

5000

3000

1000

11000

9000

7000

5000

3000

1000

ċ

١,

3000

1000

5000

3000

1000

ò